

Notice of References Cited	Application/Control No. 10/826,003	Applicant(s)/Patent Under Reexamination SHEI ET AL.	
	Examiner Leonardo Andújar	Art Unit 2826	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,445,011	09-2002	Hirano et al.	257/99
*	B	US-2002/0008325	01-2002	Tominaga, Atsushi	257/778
	C	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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